Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
09/879,170	LEE ET AL.
Examiner	Art Unit .
XIAO M. WU	2674

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Class	Subclass	Date	Examiner
UPDATE	SEARCH	6/13/2005	X.W.
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EAST SEARCH	6/13/2005	x.w.